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### Abstract

It is shown, how the very efficient method of lines can be applied to the analysis of planar waveguides (e.g. microstrip, slotline, finline or more complex structures) on ferrite substrate transversely magnetized perpendicular to the plane of the substrate. Dispersion diagrams for microstrip on magnetized ferrite substrate obtained with a desktop computer are presented.

### Introduction

The method of lines has been proved to be very efficient [1,2] for calculating the characteristic properties of planar microwave waveguides, e.g. microstrip, slotline and finline or other structures built from them e.g. resonators, periodic structures [3]. The method has no problems with the relative convergence phenomenon, is very accurate and has low memory capacity requirements, so that even relatively complex structures can be analyzed on a desktop computer. In this contribution it will be shown, how the method of lines can be applied to shielded planar structures on ferrite substrate transversely magnetized perpendicular to the plane of the substrate. The much simpler case with transversely magnetized ferrite in the plane of the substrate is given in [4]. The structure here may contain an arbitrary number of dielectric and magnetic layers, but the principle is demonstrated for the two-layer structure in fig. 1. Because the boundary conditions at electric or magnetic side walls in this case are not homogeneous in the ferrite layer it is assumed that the structure in fig. 1 is an elementary cell of a periodic structure in x-direction.

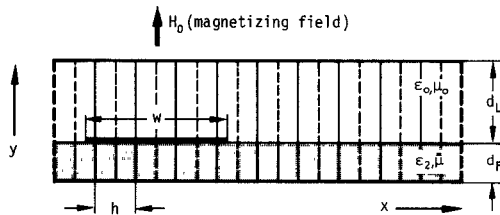


Fig. 1 Cross-section of planar microwave structure on magnetized ferrite substrate (— lines for  $E_y$  ---- lines for  $H_y$ )

The computed dispersion diagrams are compared with results of Krause [5], who used a mode matching procedure.

### Method of analysis

In the ferrite substrate Maxwell's equations for time-harmonic electromagnetic fields can be written as

$$\begin{aligned} \nabla \times \mathbf{H} &= j\omega \epsilon \mathbf{E} & \nabla \cdot (\bar{\mu} \mathbf{H}) &= 0 \\ \nabla \times \mathbf{E} &= -j\omega \bar{\mu} \mathbf{H} & \nabla \cdot \mathbf{E} &= 0 \end{aligned} \quad (1)$$

With the d.c. magnetic field  $H_0$  in y-direction the permeability tensor becomes

$$\bar{\mu} = \mu_0 \begin{bmatrix} \mu_1 & 0 & j\mu_2 \\ 0 & 1 & 0 \\ -j\mu_2 & 0 & \mu_1 \end{bmatrix}$$

$$\text{with } \mu_1 = 1 + \frac{\gamma^2 H_0^2 M_s^2}{(\gamma H_0)^2 - \omega^2}, \quad \mu_2 = \frac{\omega \gamma M_s}{(\gamma H_0)^2 - \omega^2}$$

$\gamma$  is the gyromagnetic ratio and  $M_s$  the saturation magnetization.

The propagation is assumed to be in the z-direction with  $\exp(-j\beta z)$ . According to [6] the electromagnetic field can be determined from the components in the direction of the d.c. magnetic field. The following equations are obtained for the field components  $E_y$  and  $H_y$ :

$$\frac{\partial^2 E_y}{\partial x^2} + \frac{\partial^2 E_y}{\partial y^2} - \beta^2 E_y + \mu_f k_f^2 E_y = k_f \eta \frac{\mu_2}{\mu_1} \frac{\partial H_y}{\partial y} \quad (3)$$

$$\frac{\partial^2 H_y}{\partial x^2} + \frac{1}{\mu_1} \frac{\partial^2 H_y}{\partial y^2} - \beta^2 H_y + k_f^2 H_y = - \frac{k_f}{\eta} \frac{\mu_2}{\mu_1} \frac{\partial E_y}{\partial y} \quad (4)$$

with

$$\mu_f = \mu_1 - \mu_2^2 / \mu_1, \quad k_f^2 = \omega^2 \epsilon_2 \mu_0, \quad \eta = (\mu_0 / \epsilon_2)^{1/2}$$

The boundary conditions on a wall in the y-z-plane are as follows:

Electrical wall:

$$E_y (=E_z) = 0; \quad \frac{\partial H_y}{\partial x} = -j \frac{\mu_2}{\mu_1} \frac{\partial H_z}{\partial y} \quad (5)$$

Magnetic wall:

$$H_y (=H_z) = 0; \quad \frac{\partial E_y}{\partial x} = -\mu_2 n k_f H_x \quad (6)$$

In order to solve these equations, the fields are phase normalized by multiplying with  $e^{jbx}$  and discretized with respect to the x-variable with interval size  $h$  (fig.1). The discretization lines for  $E_y$  and  $H_y$  are shifted with respect to each other in order to obtain smaller discretization errors [1]. The partial derivatives with respect to  $x$  can be written as

$$h e^{jbx} \frac{\partial E_y}{\partial x} \rightarrow [D][\tilde{E}_y]; [\tilde{E}_y] = \text{diag}[e^{jbh(i+\frac{1}{2})}] \quad (7)$$

$$h e^{jbx} \frac{\partial H_y}{\partial x} \rightarrow -[D]^* t [Sh] \tilde{H}_y; [Sh] = \text{diag}[e^{jbh(i+\frac{1}{2})}]$$

$$h^2 e^{jbx} \frac{\partial^2 E_y}{\partial x^2} \rightarrow -[D]^* t [D][\tilde{E}_y] \quad (8)$$

$$h^2 e^{jbx} \frac{\partial^2 H_y}{\partial x^2} \rightarrow -[D][D]^* t [Sh] \tilde{H}_y$$

where  $\tilde{H}_y$  and  $\tilde{E}_y$  are the column vectors of discretized fields. The lateral boundary conditions must be included in the difference-operators. Because of the partially nonhomogeneous conditions in eq.(5) and (6) this is not possible in simple way. Therefore periodic conditions are assumed, that means that according to Floquets theorem we introduce

$$F_{i+ph} = F_i e^{-jbhph} = F_i S_1^{-p} \quad (9)$$

where  $F_i$  stands for anyone of the field components at line  $i$  and  $ph$  is the length of the period.  $bhph$  may be chosen to 0 or  $\pi$ . The difference-operators are given now as

$$[D] = \begin{bmatrix} -S^* & & \\ & \ddots & \\ S^* & & -S \end{bmatrix}; [D][D]^* t = \begin{bmatrix} 2 & -S_1^* & & -S_1 \\ -S_1 & & & \\ & \ddots & & \\ -S_1^* & & -S_1^* & 2 \end{bmatrix} \quad (10)$$

with  $S_1 = S^{*2}$ .

By means of the orthogonal transformation matrices  $[Te]$  and  $[Th]$ , of which the columns are the eigenvectors of the matrices  $[D]^* t [D]$  and  $[D][D]^* t$  respectively [1], the vectors of the discretized and phase normalized fields are transformed into the spectral domain

$$[Se] \tilde{E}_y = [Te] E_y \text{ and } [Sh] \tilde{H}_y = [Th] H_y \quad (11)$$

$$\text{with } [Te, h]^* t [D][D]^* t [Te, h] = \text{diag}[\lambda^2]$$

$$[Te]_{i,k} = \exp(j2\pi i k/p) \sqrt{p}$$

$$[Th]_{i,k} = \exp(j2\pi(i+0.5)k/p) / \sqrt{p}$$

It is found, that

$$[Te, h]^* [D][Te, h] = [\lambda] \quad \text{and}$$

$$[Th]^* t [D][Th] = j[\lambda]$$

Transforming equations (3) and (4) yields a system of ordinary differential equations

$$\left( \frac{d^2}{dy^2} + \mu_f k_f^2 - \beta^2 \right) - \frac{1}{h^2} [\lambda^2] E_y = k_f n \frac{\mu_2}{\mu_1} \frac{\partial}{\partial y} H_y \quad (12)$$

$$\left( \frac{d^2}{\mu_1 dy^2} + k_f^2 - \beta^2 \right) - \frac{1}{h^2} [\lambda^2] H_y = -\frac{k_f}{n} \frac{\mu_2}{\mu_1} \frac{\partial}{\partial y} E_y \quad (13)$$

that can be solved entirely in the spectral domain for each pair of elements  $E_{yi}$ ,  $H_{yi}$  separately. By combination a system of uncoupled fourth order differential equations for  $E_y$  or  $H_y$  can be derived:

$$\left( \left( -\frac{1}{\mu_1} \frac{d^2}{dy^2} + [\xi^h] \right) \left( \frac{d^2}{dy^2} + [\xi^e] \right) + k_f^2 \frac{\mu_2}{\mu_1} \frac{d^2}{dy^2} \right) (E_y \text{ or } H_y) = 0 \quad (14)$$

with

$$[\xi^h]_i = k_f^2 - \beta^2 - \frac{1}{h^2} [\lambda^2]_i, \quad [\xi^e]_i = \mu_f k_f^2 - \beta^2 - \frac{1}{h^2} [\lambda^2]_i$$

The solution of eqn.(14) is obtained as a superposition of two partial solutions.

$$E_{yi} = A_{1i} \cosh k_{y1i} y + A_{2i} \cosh k_{y2i} y \quad (15)$$

$$H_{yi} = B_{1i} \sinh k_{y1i} y + B_{2i} \sinh k_{y2i} y \quad (16)$$

with

$$2 \cdot (k_{y1,2}^2)_i = -\mu_1 (x \pm \sqrt{x^2 - 4 \frac{\xi^e \xi^h}{\mu_1}})_i$$

$$x_i = \left( \xi^h + \frac{1}{\mu_1} \xi^e + k_f^2 \frac{\mu_2}{\mu_1} \right)_i$$

Because of eqn.(12) and (13) the coefficients  $B_{1i}$  and  $B_{2i}$  are determined by  $A_{1i}$  and  $A_{2i}$ .

All other components in the ferrite substrate can now be expressed in terms of  $E_{yi}$  and  $H_{yi}$  and their first derivatives with respect to  $y$ .

In the dielectric layers the electromagnetic field is obtained in a similar but simpler manner with  $\mu_2 = 0$  and  $\mu_1 = 1$ .

Applying continuity conditions at the ferrite-dielectric interface yields a system of equations for the tangential electric field components and the current density distributions at the interface in the spectral domain

$$[Z] \begin{bmatrix} jz \\ jx \end{bmatrix} y = d_F = \begin{bmatrix} Ez \\ Ex \end{bmatrix} y = d_F$$

where  $[Z]$  contains for our simple structure four diagonal submatrices.

The final boundary condition,  $E_{\tan} = 0$  on the metallic parts of the interfaces or  $J_{\tan} = 0$  in the slots in a more complex structure must be imposed in the original domain, so that an inverse transformation is required. Only a few lines are required through the strips or slots. Thus, the final eigenvalue equation has a very low order and the propagation constant can be determined with relatively small effort.

#### Numerical results

For the microstrip shown in fig.(1) some numerical results are obtained. The discretization distance  $h$  is chosen such, that the strip width equals  $W = (M - .5)h$ , where  $M$  is the number of  $E_y$ -lines on the strip. The dispersion diagram for the fundamental mode fig. (2) was calculated with  $M = 4$ . The agreement with the results of Krause [5] (dashed curves) is good in the case of the normalized magnetizing field  $h_0^i = 8.1$  but for  $h_0^i = 2.0$  the difference increases with frequency.

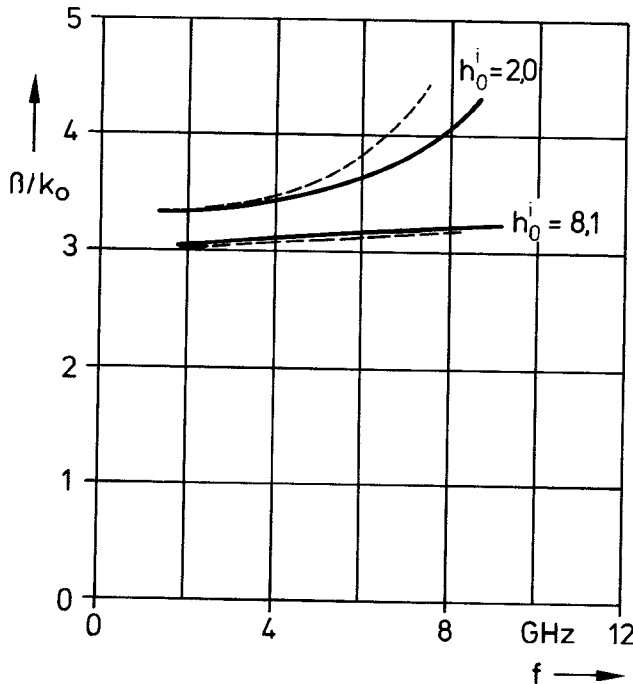


Fig. 2 Dispersion diagram for a microstrip on magnetized ferrite ( ——— this method  
----- from [5] )  
 $W = 1\text{mm}$ ,  $d_F = .635\text{ mm}$ ,  $d_1 = 5 d_F$   
 $\epsilon_{r2} = 12.3$ ,  $M_s = 1.4\text{ kA/cm}$ ,  $g = 1.98$   
 $h_0^i = H_0/M_s$

#### References

- [1] U. Schulz, R. Pregla; A new technique for the analysis of the dispersion characteristics of planar waveguides. AEU, Vol 34, pp 169-173, 1980
- [2] U. Schulz, R. Pregla; A new technique for the analysis of the dispersion characteristics of planar waveguides and its application to microstrips with tuning septums, Radio Science Vol 16, pp 1173-1178, 1981
- [3] S.B. Worm, R. Pregla; Hybrid mode analysis of arbitrarily shaped planar microwave structures by the method of lines. IEEE Transact. MTT, Febr. 1984
- [4] R. Pregla, S.B. Worm; A new technique for the analysis of planar waveguides with magnetized ferrite substrat. Proc. of the 12th European Microwave Conference, 1982, Helsinki/Finnland
- [5] N. Krause; Ein Verfahren zur Berechnung der Dispersion einer Mikrostreifenleitung auf gyotropem Substrat. AEU, Vol 31, pp 205-211, 1977
- [6] I. Wolff; A contribution to the theory of transverse magnetized ferrite. Frequenz, Vol 25, pp 235-241, 1971